



High-Q and high-gradient research updates from Cornell University

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On behalf of the SRF group of Cornell University

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Outline

- Vertical electropolishing (VEP) updates
- Bipolar electropolishing (BEP) updates
- Low-temperature doping updates



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Motivation of Vertical Electropolishing

- VEP has lower cost compared to horizontal EP;
- VEP requires smaller space for the system set-up;
- VEP'd SRF cavities have similar performance compared with HEP'd cavities.

Cornell VEP system for the ILC R&D project (high-gradient research)

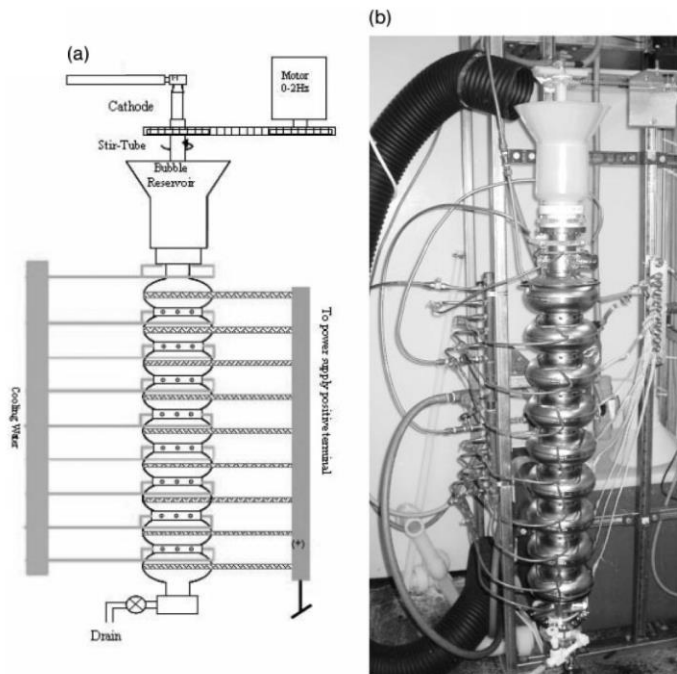
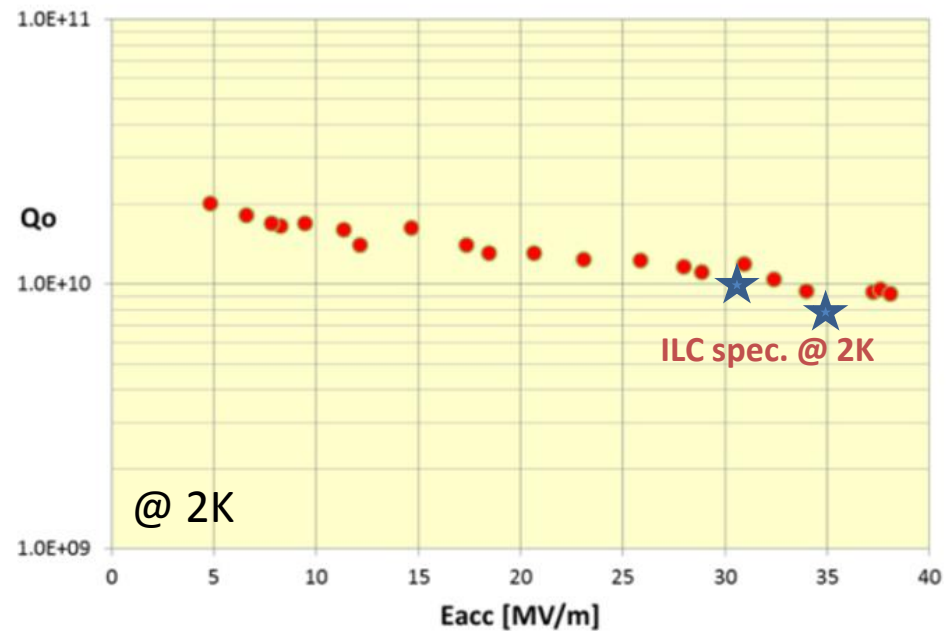


Fig. 7.12 Vertical electropolishing: (a) schematic layout; (b) photograph of the setup [434].

Cornell VEP for 9-cell set-up



High gradient achievement of Cornell's VEP
with 1.3GHz TESLA shape 9-cell.

**Cornell Vertical electropolished 9-cell and single-cell SRF cavities
achieved the ILC specification at 2K ($E_{acc} > 35 \text{ MV/m}$ with $Q_0 > 0.8e10$)**

Cornell VEP system for the LCLS-II R&D project (high- Q_0 research)

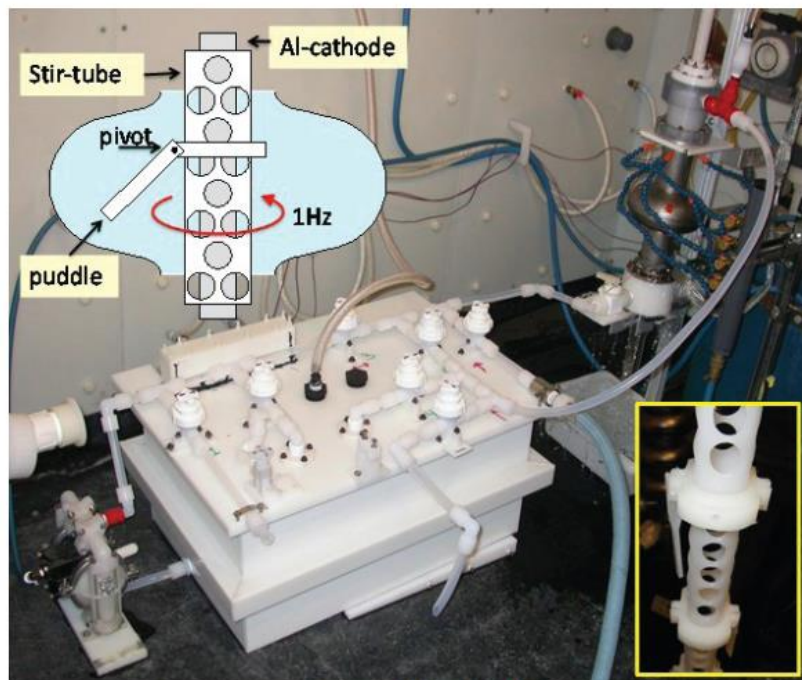
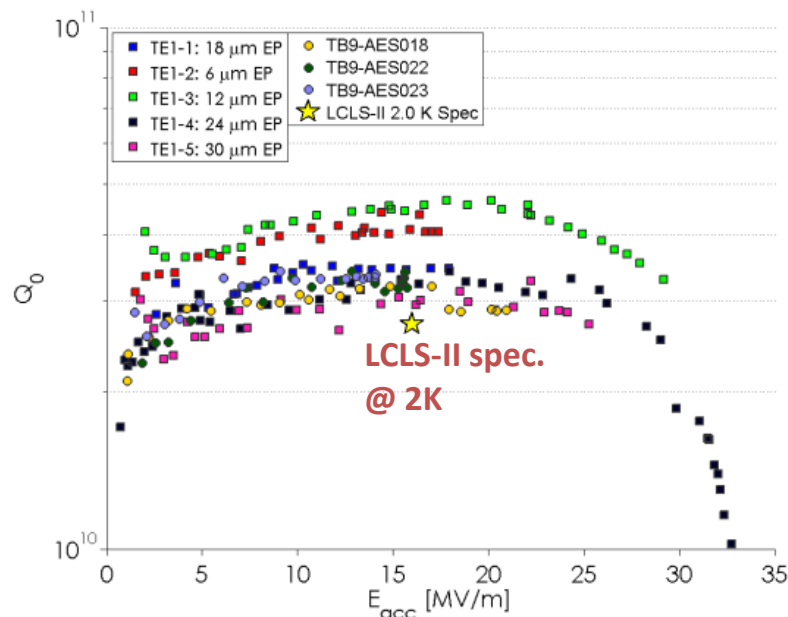


Figure 1: Cornell's VEP system.



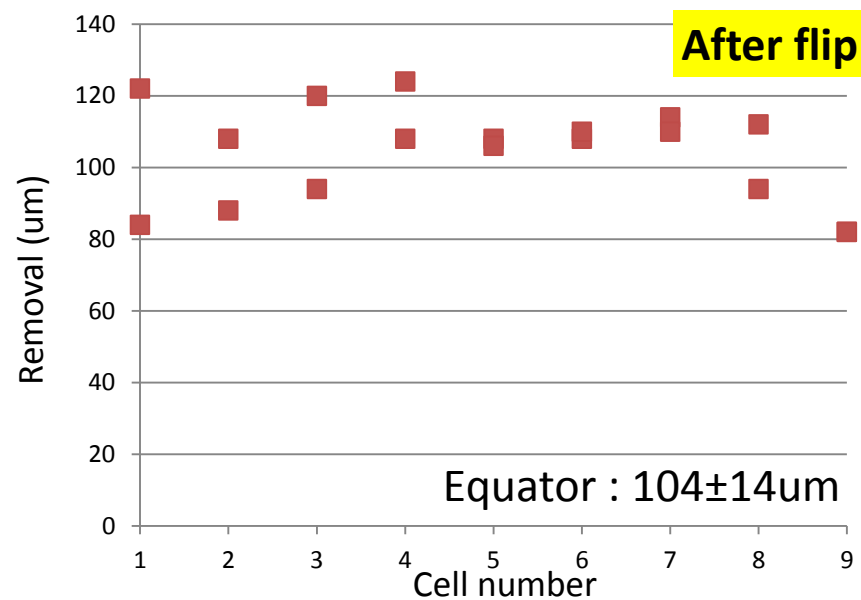
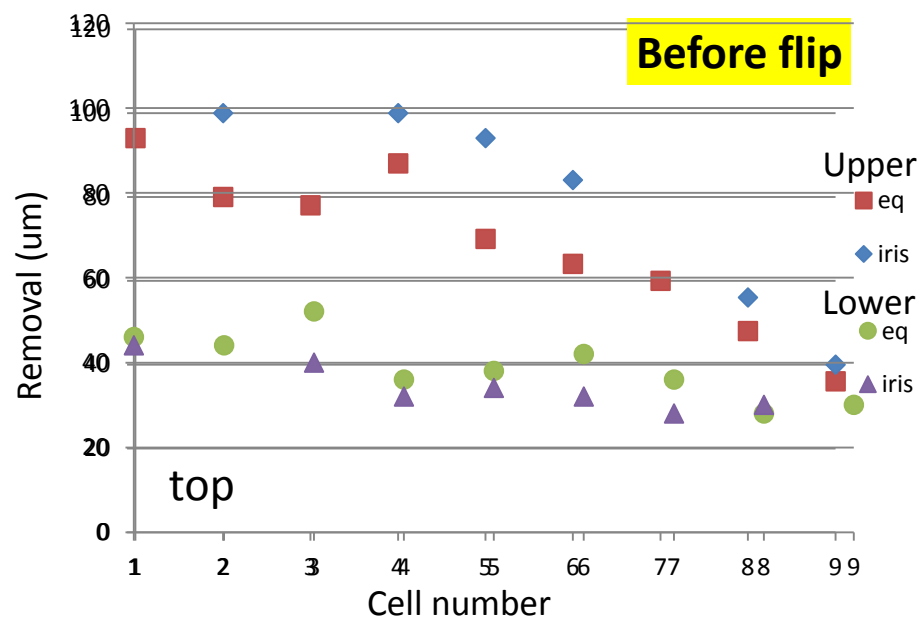
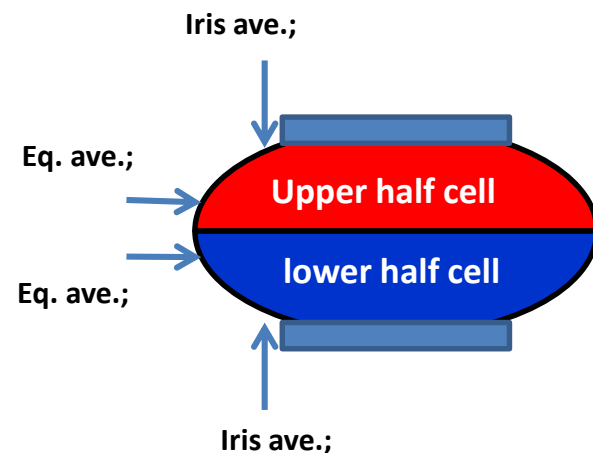
Q_0 vs E_{acc} performance and 2.0 K for all eight cavities. Errors are 20% on Q_0 and 10% on E_{acc}

The nitrogen-doped 9-cell and single-cell SRF cavities after VEP all achieved the LCLS-II specification ($E_{acc} > 16 \text{ MV/m}$, $Q_0 > 2.7 \times 10^{10}$ at 2K)

Motivation of Ninja cathode development

(collaborated with KEK and Marui)

- Gravity effect causes VEP removal un-uniform;
- Cavity has to be flipped in a VEP;
- Ninja Cathode has been designed to compensate the removal un-uniform;



Ninja cathode development in collaboration with KEK and Marui

Cornell's and Marui's VEP Cathode

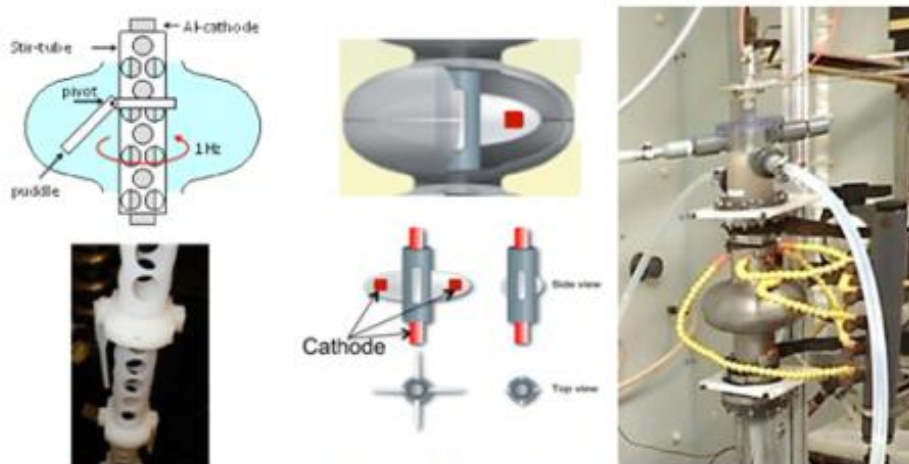


Figure 1: Images of Cornell VEP cathode (left); Marui's i-cathode Ninja type-I (middle), and single cell on the VEP stand at Cornell.

Surface preparation of NR1-2:

- NR1-2: CBP (30 μ m)+BCP (60 μ m)+800C baking (2hrs),
- Two VEPs (20 μ m each) using the Ninja cathodes of type-I & II,
- 120C baking (48hrs) and RF test,
- NR1-2 treated by the Ninja cathode achieved the ILC spec.

Removal [μ m]	Target
(preliminary)	Top half cell
	Bottom half cell

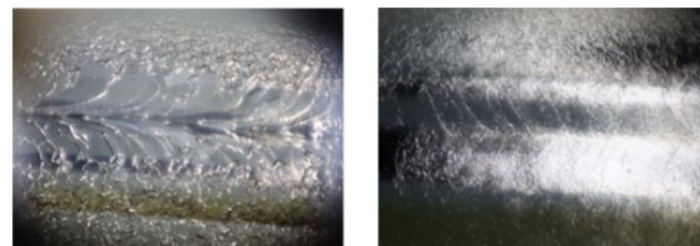
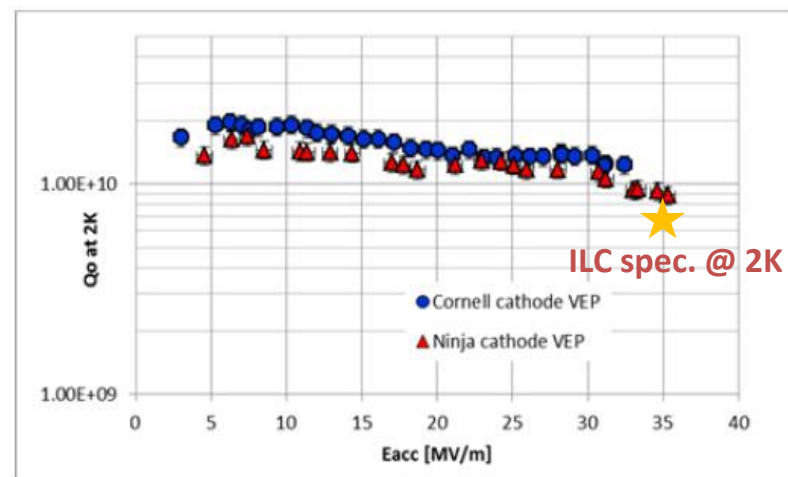


Figure 2: Optical inspection images of the equator weld seam on the RF surface; Cornell VEP (left), Ninja cathode type-I (right).



RF test results of NR1-2 at 2K.

Cornell cathode	Ninja type-I	Ninja type-II
20	20	20
24	36	29
14	20	18




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Motivation of Bipolar-EP

- Regular EP contains HF.
- HF is toxic ! A yellow triangular hazard symbol with a black border, containing a black skull and crossbones and the word "TOXIC" in black capital letters.
- Regular EP will require >10,000 liters HF acid for ILC project (~8000 1.3GHz 9-cell SRF cavities).

Bipolar-EP development collaborated with Faraday Inc.

(HF-free EP technique using H_2SO_4 acid)



BEP setup of 9-cell and single-cell
SRF cavities

Anodic Pulse "Tuned" to:

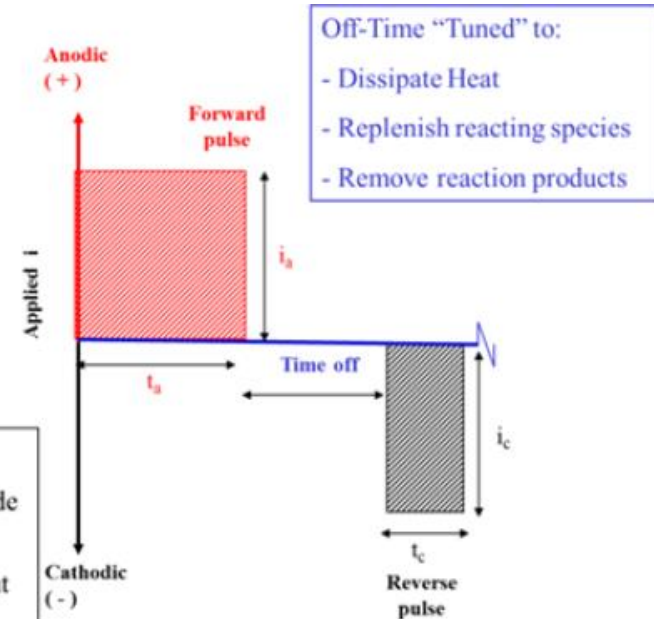
- Focus current distribution

→ Eliminates need for viscous electrolytes

Cathodic Pulse "Tuned" to:

- Depassivate surface/remove oxide

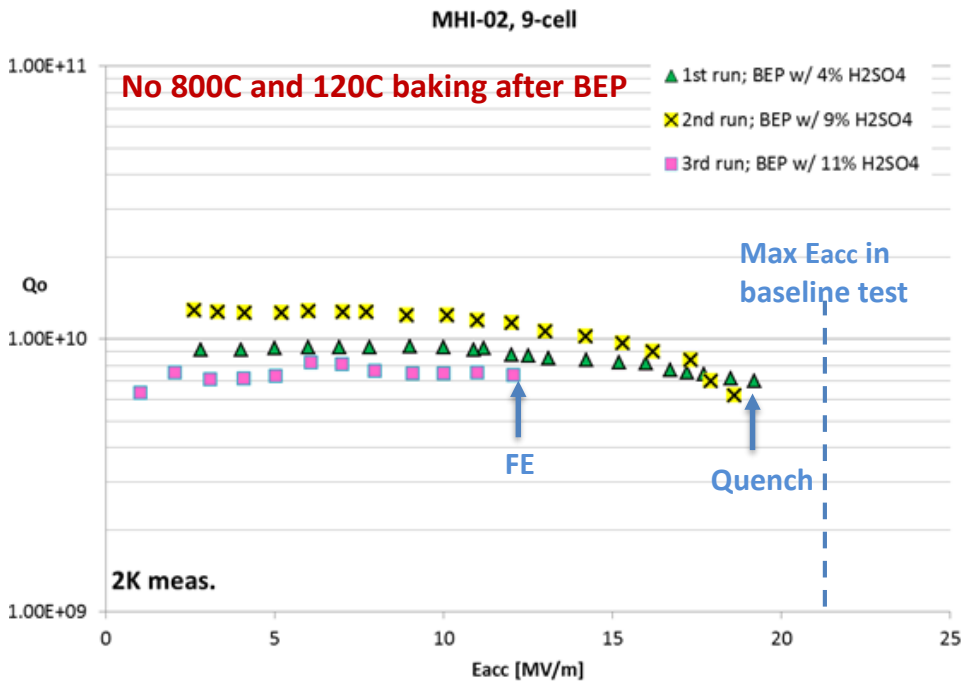
→ Eliminate need for HF, and/or low water content electrolytes?



1. an anodic forward pulse to grow an oxide layer on niobium surface,
2. voltage time off to dissipate the heat, remove reaction products, and replenishes reacting species;
3. a cathodic pulse with reversed voltage to remove the oxide layer on the niobium surface, thus eliminating the need for HF.



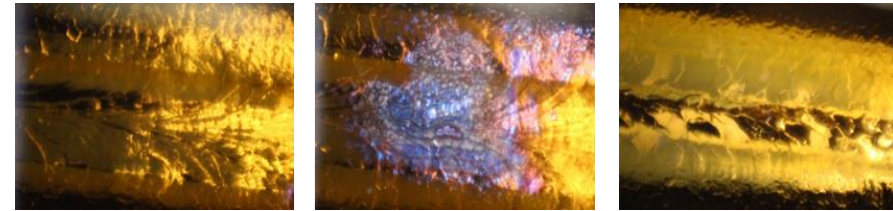
9-cell cavity BEP results



- Baseline test: cavity quenched at 22MV/m,
- BEP degraded gradient ~ 4 MV/m,
- Gradient was limited by quench and FE,
- Low Q₀ due to the oxide layer on surface.

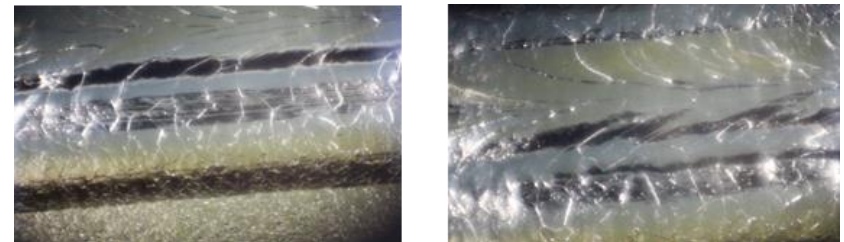
Optical inspection images:

- 1st Run:



Surface coated with thick and golden oxide layer after 63 μ m BEP of the 9-cell cavity.

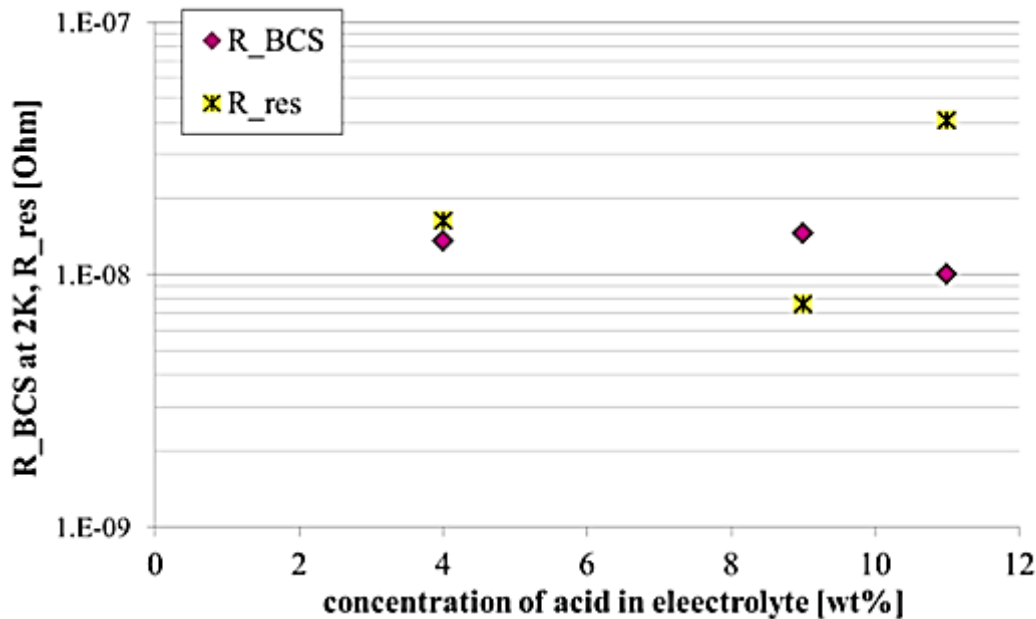
- 2nd Run: BEP 8.5 μ m, surface looks similar to the conventional EP surface;
- 3rd Run: BEP 7 μ m, surface has light yellow layer.



	wt% H ₂ SO ₄	Anodic pulse	Time off	Cathodic pulse	Remov- al
1 st run	4%	4V, 200ms	800ms	10V, 200ms	63 μ m
2 nd run	9%	4V, 100ms	600ms	10V, 200ms	8.5 μ m
3 rd run	11%	4V, 100ms	600ms	10V, 200ms	6.9 μ m



Surface resistance analysis of the 9-cell cavity results



BEP on 9-cell	w/w% H2SO4	Q at 2K, 5MV/m	R _{bs} at 2K	R _{res}
1 st run	4%	0.93e10	14 nΩ	16 nΩ
2 nd run	9%	1.26e10	15 nΩ	8 nΩ
3 rd run	11%	0.53e10	10 nΩ	41 nΩ

- BCS resistance (R_{BCS}) is $\sim 10\text{-}15\text{ n}\Omega$, which is regular to a normal VEP
- Residual resistance (R_0) has large scattering from 8 to 41 $\text{n}\Omega$.

Single-cell cavity-string BEP results

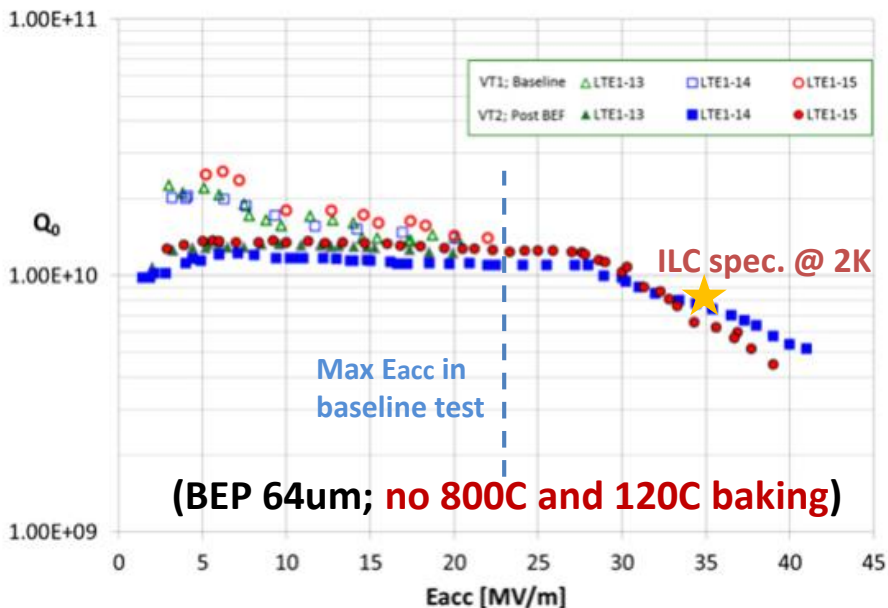


Table 1: Summary of the $E_{acc, max}$ and Q_0 at 2K

	1 st run; Baseline RF test		2 nd run; RF test post BEP	
	$E_{acc} max, Q_0$ at 2K		$E_{acc} max, Q_0$ at 2K	
LTE1-13	20MV/m	1.4E+10	20MV/m	1.22E+10
LTE1-14	20MV/m	1.4E+10	41MV/m	5.2E+09
LTE1-15	22MV/m	1.4E+10	39MV/m	4.5E+09

- Baseline test: Eacc ~20MV/m limited by quench,
- BEP improved two single-cell Eacc up to ~40MV/m,
- Q₀ is flat when Eacc is between 5-30MV/m,
- high-field Q-slope started after 30MV/m.

Optical Inspection comparison



Cornell VEP



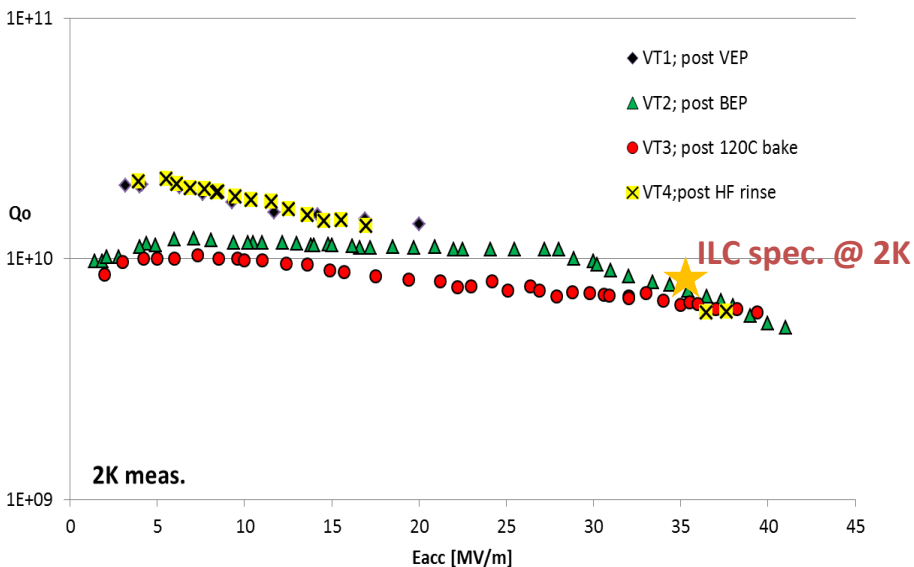
BEP



Post treatment study after BEP

- HF rinsing to remove bad oxide layer;
- 120C baking to improve Q

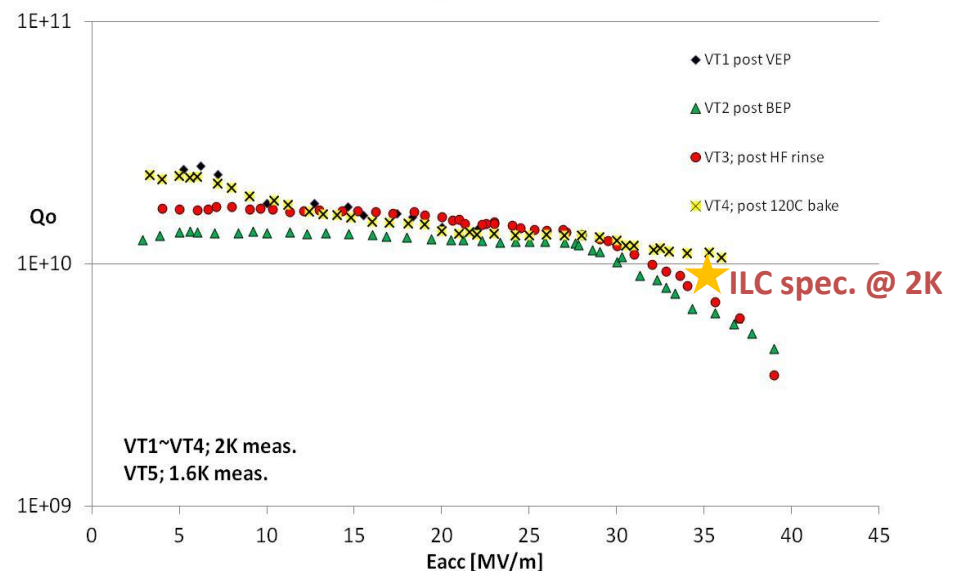
Single, LTE1-14



LET1-14:

- 1) **120C baking:** Q_0 degraded at low, medium fields; no change at high fields. $E_{acc} \sim 40$ MV/m.
- 2) **HF rinsing:** Q_0 was improve at low fields; no change at high fields. $E_{acc} \sim 40$ MV/m.

Single, LTE1-15



LET1-15:

- 1) **HF rinsing:** Q_0 was improved at low, medium fields; no change at high fields. $E_{acc} \sim 40$ MV/m.
- 2) **120C baking :** Q_0 was improve at low fields; no high-field Q-slope. E_{acc} quenched at 38 MV/m.



Conclusions of BEP study

- Gradient of the BEP'd cavities can achieve $\sim 40\text{MV/m}$,
- Q_0 varies from $\sim 8\text{e}9$ to $1.2\text{e}10$ based on BEP parameters,
- The post treatments can reduce surface resistance of BEP'd cavity down to conventional VEP level.

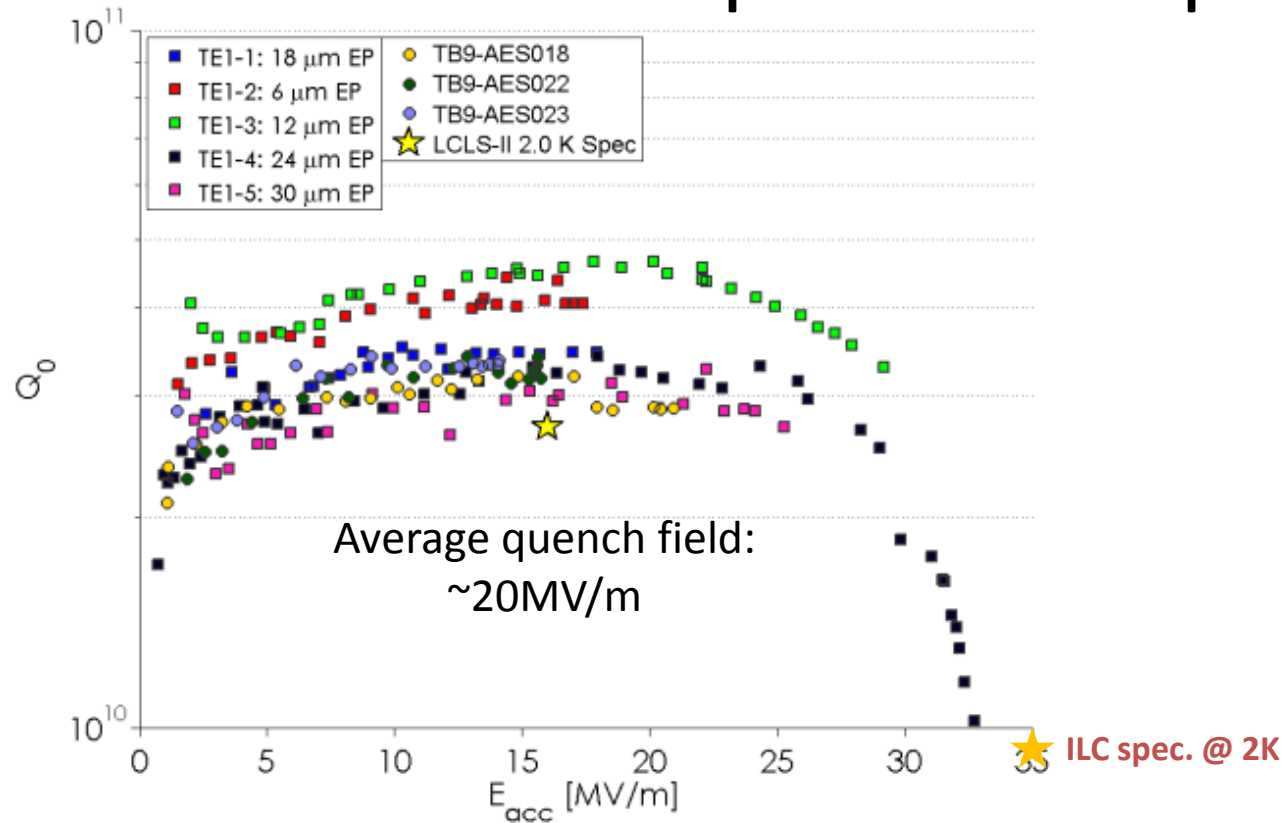


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Motivation of Low-temperature doping



- High-temperature (800C) doping cavity has high-Q, but gradient of most cavities does not achieve the ILC specification;
- Low-temperature (120-160C) doping might be a solution for producing high-Q and high-gradient cavities.

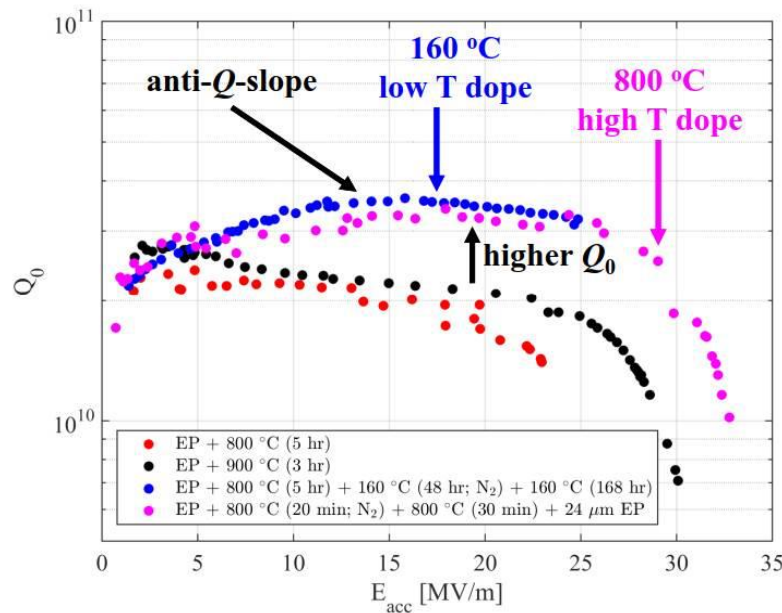


Low-temperature doping at Cornell

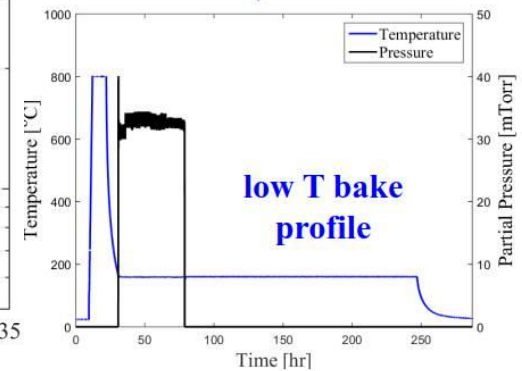
- Low temperature baking (**120 – 160 °C**) in a low pressure **nitrogen** atmosphere results in ‘ **Q -rise**’ and **higher low-field Q_0 values**

A. Grassellino *et al.*, *Unprecedented Quality Factors at Accelerating Gradients up to 45 MV/m in Niobium Superconducting Resonators via Low Temperature Nitrogen Infusion*. [arXiv:1701.06077](https://arxiv.org/abs/1701.06077).

P. N. Koufalas, D. L. Hall, M. Liepe, J. T. Maniscalco. *Effects of Interstitial Oxygen and Carbon on Niobium Superconducting Cavities*. [arXiv:161208291](https://arxiv.org/abs/161208291).



Continuously flowing
 N_2 atmosphere!



- Nitrogen diffuses **only 2 – 5 nm** into niobium at these temperatures
- Observed that **carbon** and **oxygen** diffuse **significantly** into niobium at **160 °C**

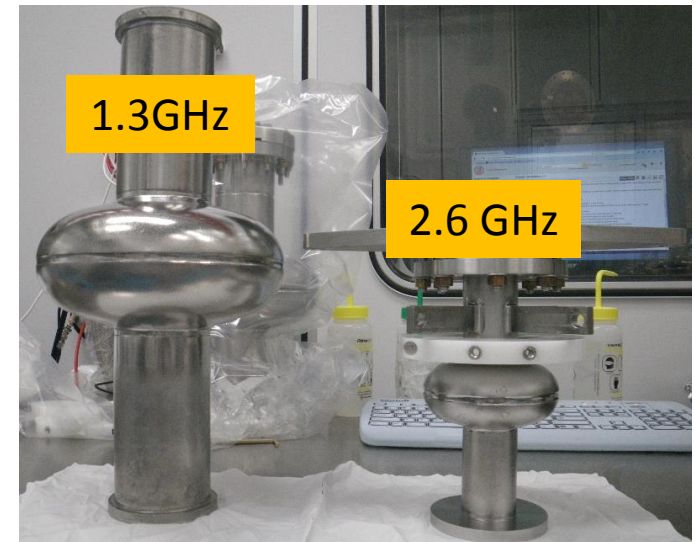
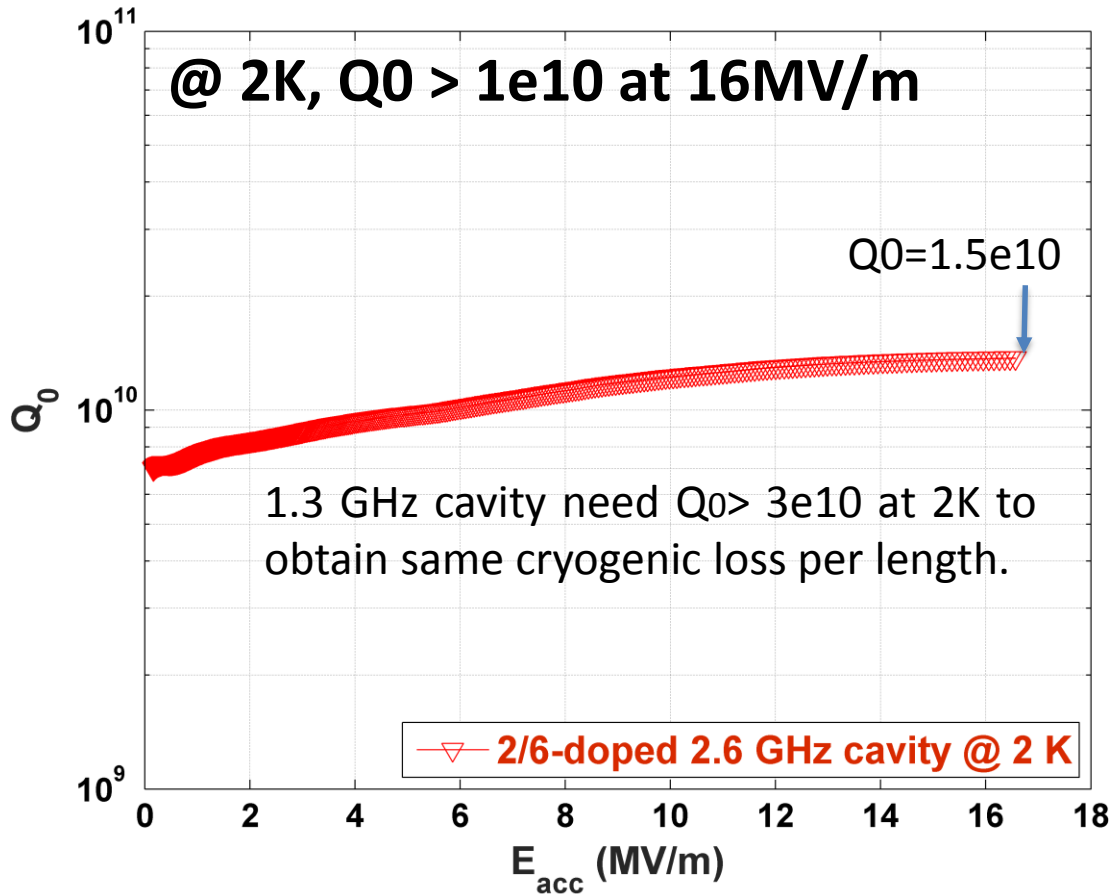


Cornell Laboratory for
Accelerator-based Sciences and
Education (CLASSE)



One more thing...

Latest results of **2.6GHz** Nitrogen-doped single-cell SRF cavity



- **2/6 Doping recipe;**
- **Q-value is comparable with a 1.3GHz EP'd cavity (non-doped);**
- **$R_{BCS} \sim 11 \text{ n}\Omega$ at 16MV/m;**
- **$R_0 \sim 8 \text{ n}\Omega$**
- **$E_{pk}/E_{acc} = 1.86$**
- **$B_{pk}/E_{acc} = 4.25 \text{ mT/ (MV/m)}$**



Acknowledgement

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P. Bishop, H. Conklin, F. Furuta, T. Gruber, A. Holic,
J. Kaufman, P. Koufalis, G. Kulina, M. Liepe, J.
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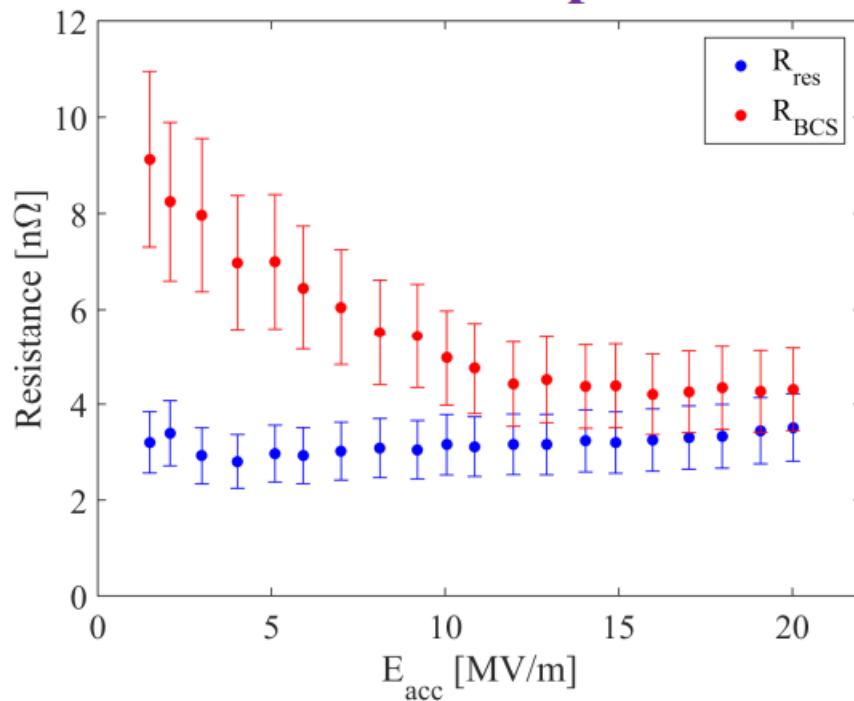
Thanks for your attention!



Surface resistance analysis of low T doping results

- R_{BCS} **decreases** with increasing E_{acc} ; **same effect** seen in **high- T nitrogen-doped** cavities (caused by reduction of mean free path!)

Low T Dope



High T Dope

